

<b>Notice of References Cited</b>	Application/Control No. 10/085,044	Applicant(s)/Patent Under Reexamination MIYAKOSHI ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,125,122	09-2000	Favichia et al.	370/466
	B	US-2002/0065099	05-2002	BJORND AHL, PER	455/553
	C	US-6,285,659	09-2001	Feuerstraeter et al.	370/244
	D	US-6,425,019	07-2002	Tateyama et al.	710/11
	E	US-6,504,851	01-2003	Abler et al.	370/466
	F	US-6,425,019	07-2002	Tateyama et al.	710/11
	G	US-5,586,117	12-1996	Edem et al.	370/466
	H	US-6,507,734	01-2003	Berger et al.	455/410
	I	US-6,832,082	12-2004	Ramaswamy et al.	455/411
	J	US-4,736,404	04-1988	Anglikowski et al.	455/411
	K	US-2002/0197985	12-2002	Tourrilhes et al.	455/420
	L	US-2003/0078036	04-2003	Chang et al.	455/419
	M	US-5,142,528	08-1992	Kobayashi et al.	370/469

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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